

# CD54HC109/3A

# CD54HCT109/3A

**Switching Speed** (Limits with black dots (•) are tested 100%.)

**SWITCHING CHARACTERISTICS** ( $C_L = 50$  pF, Input  $t_r, t_f = 6$  ns)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS $V_{CC}$ V	LIMITS								UNITS	
			25° C				-55° C to +125° C					
			HC		HCT		54HC		54HCT			
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
Propagation Delay CP → Q, $\bar{Q}$	$t_{PLH}$ $t_{PHL}$	2	—	175	—	—	—	—	265	—	—	ns
		4.5	—	35•	—	40•	—	53•	—	60•		
		6	—	30	—	—	—	45	—	—		
$\bar{S} \rightarrow Q$	$t_{PLH}$	2	—	120	—	—	—	180	—	—		
		4.5	—	24•	—	30•	—	36•	—	45•		
		6	—	20	—	—	—	31	—	—		
$\bar{S} \rightarrow \bar{Q}$	$t_{PHL}$	2	—	155	—	—	—	235	—	—		
		4.5	—	31	—	45	—	47	—	68		
		6	—	26	—	—	—	40	—	—		
$\bar{R} \rightarrow Q$	$t_{PHL}$	2	—	185	—	—	—	280	—	—		
		4.5	—	37	—	45	—	56	—	68		
		6	—	31	—	—	—	48	—	—		
$\bar{R} \rightarrow \bar{Q}$	$t_{PLH}$	2	—	170	—	—	—	255	—	—		
		4.5	—	34•	—	37•	—	51•	—	56•		
		6	—	29	—	—	—	43	—	—		
Transition Times	$t_{TLH}$ $t_{THL}$	2	—	75	—	—	—	110	—	—		
		4.5	—	15	—	15	—	22	—	22		
		6	—	13	—	—	—	19	—	—		
Input Capacitance	$C_I$	—	—	10	—	10	—	10	—	10	pF	

**Burn-In Test-Circuit Connections** (Use Static II for /3A burn-in and Dynamic for Life Test.)

Static	STATIC BURN-IN I			STATIC BURN-IN II		
	OPEN	GROUND	$V_{CC}$ (6V)	OPEN	GROUND	$V_{CC}$ (6V)
CD54HC/HCT109	6,7,9,10	1-5,8,11-15	16	6,7,9,10	8	1-5,11-16
Dynamic	OPEN	GROUND	$1/2 V_{CC}$ (3V)	$V_{CC}$ (6V)	OSCILLATOR	
CD54HC/HCT109	—	8	6,7,9,10	1-3,5,11, 13-16	50 kHz 4,12	25 kHz —

NOTE: Each pin except  $V_{CC}$  and Gnd will have a resistor of 2k-47k ohms.

## Dual J-K Flip-Flop w/SET and RESET

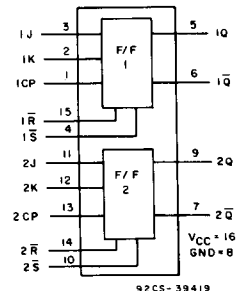
## CD54HC112/3A

## CD54HCT112/3A

The RCA-CD54HC112 and CD54HCT112 utilize silicon-gate CMOS technology to achieve operating speeds equivalent to LSTTL parts. They exhibit the low power consumption of standard CMOS integrated circuits, together with the ability to drive 10 LSTTL loads.

These flip-flops have independent J, K, Reset and Clock inputs and Q and  $\bar{Q}$  outputs. They change state on the negative-going transition of the clock pulse. Set and reset are accomplished asynchronously by low-level inputs.

The 54HCT logic family is functionally as well as pin compatible with the standard 54LS logic family.



92CS-39419

### Package Specifications

See Section 11, Fig. 11

### FUNCTIONAL DIAGRAM

# CD54HC112/3A

# CD54HCT112/3A

## Static Electrical Characteristics (Limits with black dots (•) are tested 100%)

CHARACTERISTICS		TEST CONDITIONS								UNITS
		HC/HCT				V <sub>IN</sub>		LIMITS		
		V <sub>DD</sub>	V <sub>O</sub>	I <sub>O</sub>	V <sub>CC</sub> or GND	V <sub>IL</sub> or V <sub>IH</sub>	V <sub>IL</sub> or V <sub>IH</sub>	MIN.	MAX.	
Quiescent Device Current I <sub>CC</sub>	25°C	6	—	—	6, 0	—	—	—	4•	μA
	-55°C	6	—	—	6, 0	—	—	—	80•	
	+125°C	6	—	—	6, 0	—	—	—	80•	

The complete static electrical test specification consists of the above by-type static tests combined with the standard static tests in the beginning of this section.

### HCT INPUT LOADING TABLE

INPUT	UNIT LOAD*
1S, 2S	0.5
1K, 2K	0.6
1R, 2R	0.65
1J, 2J, 1CP, 2CP	1

\*Unit load is ΔI<sub>CC</sub> limit specified in Static Characteristics Chart, e.g., 360 μA max. @ 25°C.

## Switching Speed (Limits with black dots (•) are tested 100%.)

### SWITCHING CHARACTERISTICS (C<sub>L</sub> = 50 pF, Input t<sub>r</sub>, t<sub>f</sub> = 6 ns)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	LIMITS								UNITS
			25°C				-55°C to +125°C				
			HC		HCT		54HC		54HCT		
Propagation Delay <u>CP</u> to Q, <u>Q̄</u>	t <sub>PLH</sub> t <sub>PHL</sub>	2	—	175	—	—	—	265	—	—	ns
		4.5	—	35•	—	35•	—	53•	—	53•	
		6	—	30	—	—	—	45	—	—	
		2	—	155	—	—	—	235	—	—	
		4.5	—	31•	—	32•	—	47•	—	48•	
		6	—	26	—	—	—	40	—	—	
Propagation Delay <u>S</u> to Q, <u>Q̄</u>	t <sub>PLH</sub> t <sub>PHL</sub>	2	—	180	—	—	—	270	—	—	ns
		4.5	—	36•	—	37•	—	54•	—	56•	
		6	—	31	—	—	—	46	—	—	
		2	—	75	—	—	—	110	—	—	
		4.5	—	15	—	15	—	22	—	22	
		6	—	13	—	—	—	19	—	—	
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>	2	—	75	—	—	—	110	—	—	ns
		4.5	—	15	—	15	—	22	—	22	
		6	—	13	—	—	—	19	—	—	
Input Capacitance	C <sub>i</sub>	—	—	10	—	10	—	10	—	10	pF

## Burn-In Test-Circuit Connections (Use Static II for /3A burn-in and Dynamic for Life Test.)

Static	STATIC BURN-IN I			STATIC BURN-IN II		
	OPEN	GROUND	V <sub>CC</sub> (6V)	OPEN	GROUND	V <sub>CC</sub> (6V)
CD54HC/HCT112	5-7,9	1-4,8,10-15	16	5-7,9	8	1-4,10-16
Dynamic	OPEN	GROUND	1/2 V <sub>CC</sub> (3V)	V <sub>CC</sub> (6V)	OSCILLATOR	
CD54HC/HCT112	—	8	5-7,9	2-4,10-12, 14-16	1,13	25 kHz

NOTE: Each pin except V<sub>CC</sub> and Gnd will have a resistor of 2k-47k ohms.